

Notice of References Cited	Application/Control No. 10/617,252	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Anh T.N. Vo	Art Unit 2861	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,211,936	04-2001	Nakamura, Teruya	349/152
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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